

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under

Reexamination

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Examiner

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Art Unit

2633

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,211,980	04-2001	Terahara, Takafumi	398/82
	B	US-5,452,124	09-1995	Baker, Phillip E.	359/341.2
	C	US-5,748,363	05-1998	Duck et al.	398/180
	D	US-6,061,484	05-2000	Jones et al.	385/24
	E	US-6,160,660	12-2000	Aina et al.	359/341.2
	F	US-6,310,994	10-2001	Jones et al.	385/24
	G	US-6,313,933	11-2001	Iwano, Tadayuki	398/9
	H	US-6,327,060	12-2001	Otani et al.	398/83
	I	US-6,377,373	04-2002	Kawazawa et al.	398/82
	J	US-6,381,049	04-2002	Xu et al.	398/82
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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